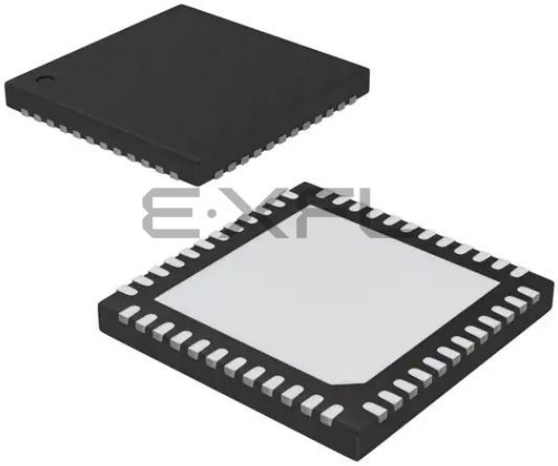
Lattice Semiconductor Corporation - ICE40UP5K-SG48I Datasheet



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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	660
Number of Logic Elements/Cells	5280
Total RAM Bits	1171456
Number of I/O	39
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	48-VFQFN Exposed Pad
Supplier Device Package	48-QFN (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/ice40up5k-sg48i

Acronyms in This Document

A list of acronyms used in this document.

Acronym	Definition
DFF	D-style Flip-Flop
DSP	Digital Signal Processor
EBR	Embedded Block RAM
HFOSC	High Frequency Oscillator
I^2C	Inter-Integrated Circuit
LFOSC	Low Frequency Oscillator
LUT	Look Up Table
LVCMOS	Low-Voltage Complementary Metal Oxide Semiconductor
NVCM	Non Volatile Configuration Memory
PCLK	Primary Clock
PFU	Programmable Functional Unit
PIC	Programmable I/O Cells
PLB	Programmable Logic Blocks
PLL	Phase Locked Loops
SoC	System on a Chip
SPI	Serial Peripheral Interface
SPR	Single Port RAM
WLCSP	Wafer Level Chip Scale Packaging

1. General Description

iCE40 UltraPlus family from Lattice Semiconductor is an ultra-low power FPGA and sensor manager designed for ultra-low power mobile applications, such as smartphones, tablets and hand-held devices. iCE40 UltraPlus is compatible with Lattice's iCE40 Ultra family devices, containing all the functions iCE40 Ultra family has except the high current IR LED driver. In addition, the iCE40 UltraPlus features an additional 1 Mb SRAM, additional DSP blocks, with additional LUTs, all which can be used to support an always-on Voice Recognition function in the mobile devices, without the need to keep the higher power consuming voice codec on all the time.

The iCE40 UltraPlus family includes integrated SPI and I^2C blocks to interface with virtually all mobile sensors and application processors. In addition, the iCE40 UltraPlus family also features two I/O pins that can support the interface to I3C devices. There are two on-chip oscillators, 10 kHz and 48 MHz, the LFOSC (10 kHz) is ideal for low power function in always-on applications, while HFOSC (48 MHz) can be used for awaken activities.

The iCE40 UltraPlus family also features DSP functional block to off-load Application Processor to pre-process information sent from the mobile device, such as voice data. The RGB PWM IP, with the three 24 mA constant current RGB outputs on the iCE40 UltraPlus provides all the necessary logic to directly drive the service LED, without the need of external MOSFET or buffer.

The iCE40 UltraPlus family of devices are targeting for mobile applications to perform all the functions in iCE40 Ultra devices, such as Service LED, GPIO Expander, SDIO Level Shift, and other custom functions. In addition, the iCE40 UltraPlus family devices are also targeting for Voice Recognition application.

The iCE40 UltraPlus family features two device densities, 2800 to 5280 Look Up Tables (LUTs) of logic with programmable I/Os that can be used as either SPI/I^2C interface ports or general purpose I/O's. Two of the iCE40 UltraPlus I/Os can be used to interface to higher performance I3C. It also has up to 120 kb of Block RAMs, plus 1024 kb of Single Port SRAMs to work with user logic.

1.1. Features

- Flexible Logic Architecture
  - Two devices with 2800 to 5280 LUTs
  - Offered in WLCS and QFN packages
- Ultra-low Power Devices
  - Advanced 40 nm low power process
  - As low as 100 µA standby current typical
- Embedded Memory
  - Up to 1024 kb Single Port SRAM
  - Up to 120 kb sysMEM™ Embedded Block RAM
- Two Hardened I^2C Interfaces
  - Two I/O pins to support I3C interface
- Two Hardened SPI Interfaces
- Two On-Chip Oscillators
  - Low Frequency Oscillator – 10 kHz
  - High Frequency Oscillator – 48 MHz
- 24 mA Current Drive RGB LED Outputs
  - Three drive outputs in each device
  - User selectable sink current up to 24 mA
- On-chip DSP
  - Signed and unsigned 8-bit or 16-bit functions
  - Functions include Multiplier, Accumulator, and Multiply-Accumulate (MAC)
- Flexible On-Chip Clocking
  - Eight low skew global signal resource, six can be directly driven from external pins
  - One PLL with dynamic interface per device
- Flexible Device Configuration
  - SRAM is configured through:
    - Standard SPI Interface
    - Internal Nonvolatile Configuration Memory (NVCM)
- Ultra-Small Form Factor
  - As small as 2.15 mm × 2.55 mm
- Applications
  - Always-On Voice Recognition Application
  - Smartphones
  - Tablets and Consumer Handheld Devices
  - Handheld Commercial and Industrial Devices
  - Multi Sensor Management Applications
  - Sensor Pre-processing and Sensor Fusion
  - Always-On Sensor Applications
  - USB 3.1 Type C Cable Detect / Power Delivery Applications

Lattice, or they can use the design to create their own unique required functions. For more information regarding Lattice's reference designs or fully-verified bitstreams, contact your local Lattice representative.

3. Architecture

3.1. Architecture Overview

The iCE40 UltraPlus family architecture contains an array of Programmable Logic Blocks (PLB), two Oscillator Generators, two user configurable I^2C controllers, two user configurable SPI controllers, blocks of sysMEM™ Embedded Block RAM (EBR) and Single Port RAM (SPRAM) surrounded by Programmable I/O (PIO). Figure 3.1 shows the block diagram of the iCE40UP5K device.

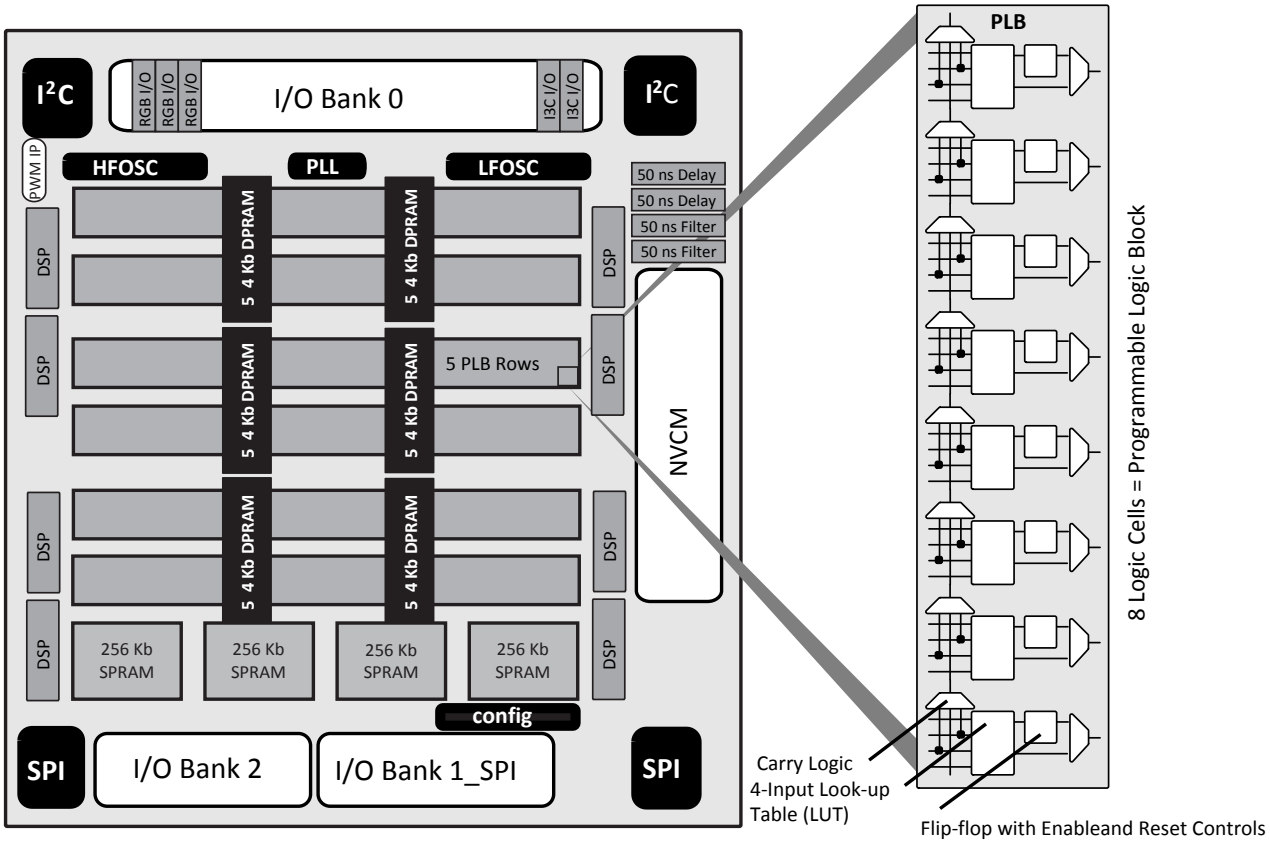

Figure 3.1. iCE40UP5K Device, Top View

The Programmable Logic Blocks (PLB) and sysMEM EBR blocks, are arranged in a two-dimensional grid with rows and columns. Each column has either PLB or EBR blocks. The PIO cells are located at the top and bottom of the device, arranged in banks. The PLB contains the building blocks for logic, arithmetic, and register functions. The PIOs utilize a flexible I/O buffer referred to as a sysIO buffer that supports operation with a variety of interface standards. The blocks are connected with many vertical and horizontal routing channel resources. The place and route software tool automatically allocates these routing resources.

In the iCE40 UltraPlus family, there are three sysIO banks, one on top and two at the bottom. User can connect some V_{CCIO}s together, if all the I/Os are using the same voltage standard. See the Power-up Supply Sequence section. The sysMEM EBRs are large 4 kb, dedicated fast memory blocks. These blocks can be configured as RAM, ROM or FIFO with user logic using PLBs.

In addition to the EBR, the iCE40 UltraPlus devices also feature four 256 kb SPRAM blocks that can be cascaded to create up to 1 Mb block. It is useful for temporary storage of large quantities of information.

Every device in the family has two user SPI ports, one of these (right side) SPI ports also supports programming and configuration of the device. The iCE40 UltraPlus also includes two user I^2C ports, two oscillators, and high current RGB LED sink.

3.1.1. PLB Blocks

The core of the iCE40 UltraPlus device consists of Programmable Logic Blocks (PLB) which can be programmed to perform logic and arithmetic functions. Each PLB consists of eight interconnected Logic Cells (LC) as shown in Figure 3.2. Each LC contains one LUT and one register.

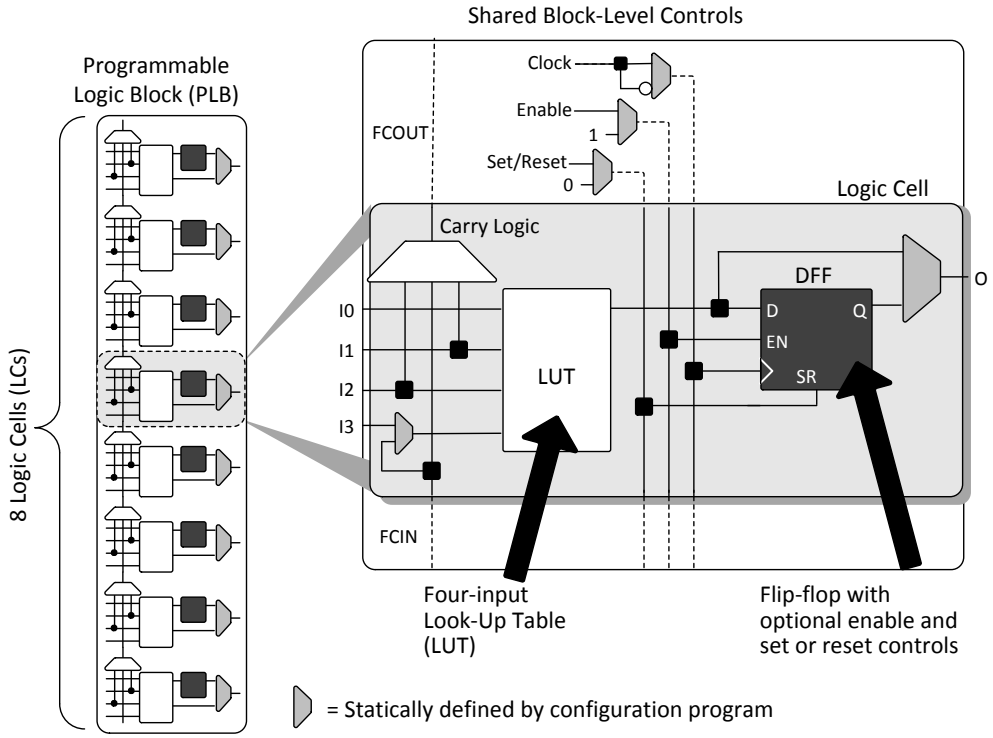

Figure 3.2. PLB Block Diagram

Logic Cells

Each Logic Cell includes three primary logic elements shown in Figure 3.2.

- A four-input Look-Up Table (LUT) builds any combinational logic function, of any complexity, requiring up to four inputs. Similarly, the LUT element behaves as a 16x1 Read-Only Memory (ROM). Combine and cascade multiple LUTs to create wider logic functions.
- A 'D'-style Flip-Flop (DFF), with an optional clock-enable and reset control input, builds sequential logic functions. Each DFF also connects to a global reset signal that is automatically asserted immediately following device configuration.
- Carry Logic boosts the logic efficiency and performance of arithmetic functions, including adders, subtracters, comparators, binary counters and some wide, cascaded logic functions.

Table 3.1 lists the logic cell signals.

Table 3.1. Logic Cell Signal Descriptions

Function	Type	Signal Name	Description
Input	Data signal	I0, I1, I2, I3	Inputs to LUT
Input	Control signal	Enable	Clock enable shared by all LCs in the PLB
Input	Control signal	Set/Reset*	Asynchronous or synchronous local set/reset shared by
Input	Control signal	Clock	Clock one of the eight Global Buffers, or from the

3.1.4. sysCLOCK Phase Locked Loops (PLLs)

The sysCLOCK PLLs provide the ability to synthesize clock frequencies. The iCE40 UltraPlus devices have one sysCLOCK PLL. REFERENCECLK is the reference frequency input to the PLL and its source can come from an external I/O pin, the internal Oscillator Generators from internal routing. EXTFEEDBACK is the feedback signal to the PLL which can come from internal routing or an external I/O pin. The feedback divider is used to multiply the reference frequency and thus synthesize a higher frequency clock output.

The PLLOUT output has an output divider, thus allowing the PLL to generate different frequencies for each output. The output divider can have a value from 1 to 64 (in increments of 2X). The PLLOUT outputs can all be used to drive the iCE40 UltraPlus global clock network directly or general purpose routing resources can be used.

The LOCK signal is asserted when the PLL determines it has achieved lock and de-asserted if a loss of lock is detected. A block diagram of the PLL is shown in Figure 3.3.

The timing of the device registers can be optimized by programming a phase shift into the PLLOUT output clock which will advance or delay the output clock with reference to the REFERENCECLK clock. This phase shift can be either programmed during configuration or can be adjusted dynamically. In dynamic mode, the PLL may lose lock after a phase adjustment on the output used as the feedback source and not relock until the tLOCK parameter has been satisfied.

There is an additional feature in the iCE40 UltraPlus PLL. There are two FPGA controlled inputs, SCLK and SDI, that allows the user logic to serially shift in data thru SDI, clocked by SCLK clock. The data shifted in would change the configuration settings of the PLL. This feature allows the PLL to be time multiplexed for different functions, with different clock rates. After the data is shifted in, user would simply pulse the RESET input of the PLL block, and the PLL will re-lock with the new settings. For more details, refer to TN1251, iCE40 sysCLOCK PLL Design and Usage Guide.

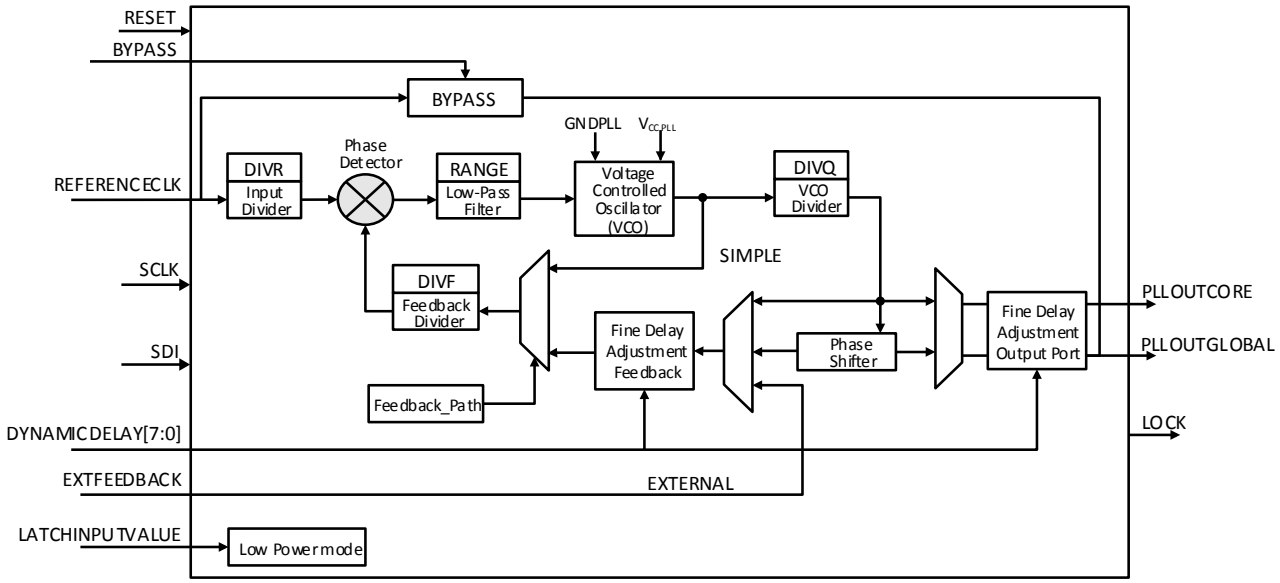

Figure 3.3. PLL Diagram

Table 3.3 provides signal descriptions of the PLL block.

Table 3.3. PLL Signal Descriptions

Signal Name	Direction	Description
REFERENCECLK	Input	Input reference clock
BYPASS	Input	The BYPASS control selects which clock signal connects to the PLLOUT output. 0 – PLL generated signal 1 – REFERENCECLK
EXTFEEDBACK	Input	External feedback input to PLL. Enabled when the FEEDBACK_PATH attribute is set to EXTERNAL.
DYNAMICDELAY[7:0]	Input	Fine delay adjustment control inputs. Enabled when DELAY_ADJUSTMENT_MODE is set to DYNAMIC.
LATCHINPUTVALUE	Input	When enabled, puts the PLL into low-power mode; PLL output is held static at the last input clock value. Set ENABLE ICEGATE_PORTA and PORTB to '1' to enable.
PLLOUTGLOBAL	Output	Output from the Phase-Locked Loop (PLL). Drives a global clock network on the FPGA. The port has optimal connections to global clock buffers GBUF4 and GBUF5.
PLLOUTCORE	Output	Output clock generated by the PLL, drives regular FPGA routing. The frequency generated on this output is the same as the frequency of the clock signal generated on the PLLOUTLGOBAL port.
LOCK	Output	When High, indicates that the PLL output is phase aligned or locked to the input reference clock.
RESET	Input	Active low reset.
SCLK	Input	Input, Serial Clock used for re-programming PLL settings.
SDI	Input	Input, Serial Data used for re-programming PLL settings.

3.1.5. sysMEM Embedded Block RAM Memory

Larger iCE40 UltraPlus device includes multiple high-speed synchronous sysMEM Embedded Block RAMs (EBRs), each 4 kbit in size. This memory can be used for a wide variety of purposes including data buffering and FIFO.

sysMEM Memory Block

The sysMEM block can implement single port, pseudo dual port, or FIFO memories with programmable logic resources. Each block can be used in a variety of depths and widths as listed in Table 3.4.

Table 3.4. sysMEM Block Configurations

Block RAM Configuration	Block RAM Configuration and Size	WADDR Port Size (Bits)	WDATA Port Size (Bits)	RADDR Port Size (Bits)	RDATA Port Size (Bits)	MASK Port Size (Bits)
SB_RAM256x16 SB_RAM256x16NR SB_RAM256x16NW SB_RAM256x16NRNW	256x16 (4 k)	8 [7:0]	16 [15:0]	8 [7:0]	16 [15:0]	16 [15:0]
SB_RAM512x8 SB_RAM512x8NR SB_RAM512x8NW SB_RAM512x8NRNW	512x8 (4 k)	9 [8:0]	8 [7:0]	9 [8:0]	8 [7:0]	No Mask Port
SB_RAM1024x4 SB_RAM1024x4NR SB_RAM1024x4NW SB_RAM1024x4NRNW	1024x4 (4 k)	10 [9:0]	4 [3:0]	10 [9:0]	4 [3:0]	No Mask Port
SB_RAM2048x2 SB_RAM2048x2NR SB_RAM2048x2NW SB_RAM2048x2NRNW	2048x2 (4 k)	11 [10:0]	2 [1:0]	11 [10:0]	2 [1:0]	No Mask Port

Table 3.6. SPRAM Signal Descriptions

Signal Name	Direction	Description
ADDRESS[13:0]	Input	Address input
DATAIN[15:0]	Input	Write Data input
MASKWREN[3:0]	Input	Nibble WE control
WREN	Input	Write Enable
CHIPSELECT	Input	Enable SPRAM
CLOCK	Input	Clock input
STANDY	Input	Standby Mode
SLEEP	Input	Sleep Mode
POWEROFF	Input	Switch off power source to SPRAM
DATAOUT[15:0]	Output	Output Data

For further information on sysMEM SPRAM block, refer to TN1314, iCE40 SPRAM Usage Guide.

3.1.7. sysDSP

The iCE40 UltraPlus family provides an efficient sysDSP architecture that is very suitable for low-cost Digital Signal Processing (DSP) functions for mobile applications. Typical functions used in these applications are Multiply, Accumulate, and Multiply-Accumulate. The block can also be used for simple Add and Subtract functions.

iCE40 UltraPlus sysDSP Architecture Features

The iCE40 UltraPlus sysDSP supports many functions that include the following:

- Single 16-bit x 16-bit Multiplier, or two independent 8-bit x 8-bit Multipliers
- Optional independent pipeline control on Input Register, Output Register, and Intermediate Reg faster clock performance
- Single 32-bit Accumulator, or two independent 16-bit Accumulators
- Single 32-bit, or two independent 16-bit Adder/Subtracter functions, registered or asynchronous
- Cascadable to create wider Accumulator blocks

Figure 3.6 shows the block diagram of the sysDSP block. The block consists of the Multiplier section with a bypassable Output register, Input Register, and Intermediate register between Multiplier and AC timing to achieve the highest performance.

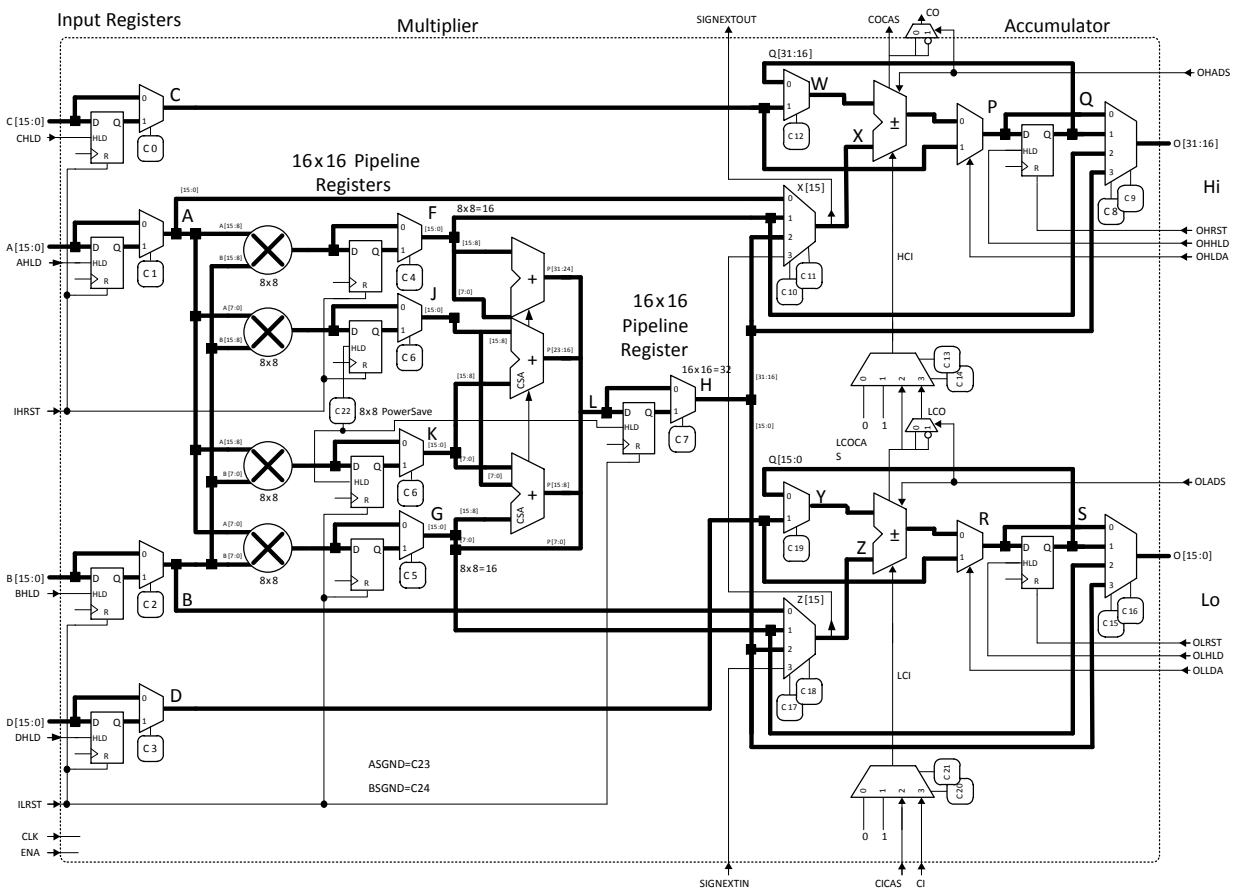

Figure 3.6. sysDSP Functional Block Diagram (16-bit x 16-bit Multiply-Accumulate)

Table 3.7. Output Block Port Description

Signal	Primitive Port Name	Width	Input/ Output	Function	Default
CLK	CLK	1	Input	Clock Input. Applies to all clocked elements in the sysDSP block	—
ENA	CE	1	Input	Clock Enable Input. Applies to all clocked elements in the sysDSP block. 0 – Not enabled 1 – Enabled	0 – Enabled
A[15:0]	A[15:0]	16	Input	Input to the A Register. Feeds the Multiplier or is a direct input to the Adder Accumulator	16'b0
B[15:0]	B[15:0]	16	Input	Input to the B Register. Feeds the Multiplier or is a direct input to the Adder Accumulator	16'b0
C[15:0]	C[15:0]	16	Input	Input to the C Register. It is a direct input to the Adder Accumulator	16'b0
D[15:0]	D[15:0]	16	Input	Input to the D Register. It is a direct input to the Adder Accumulator	16'b0
AHLD	AHOLD	1	Input	A Register Hold. 0 – Update 1 – Hold	0 – Update

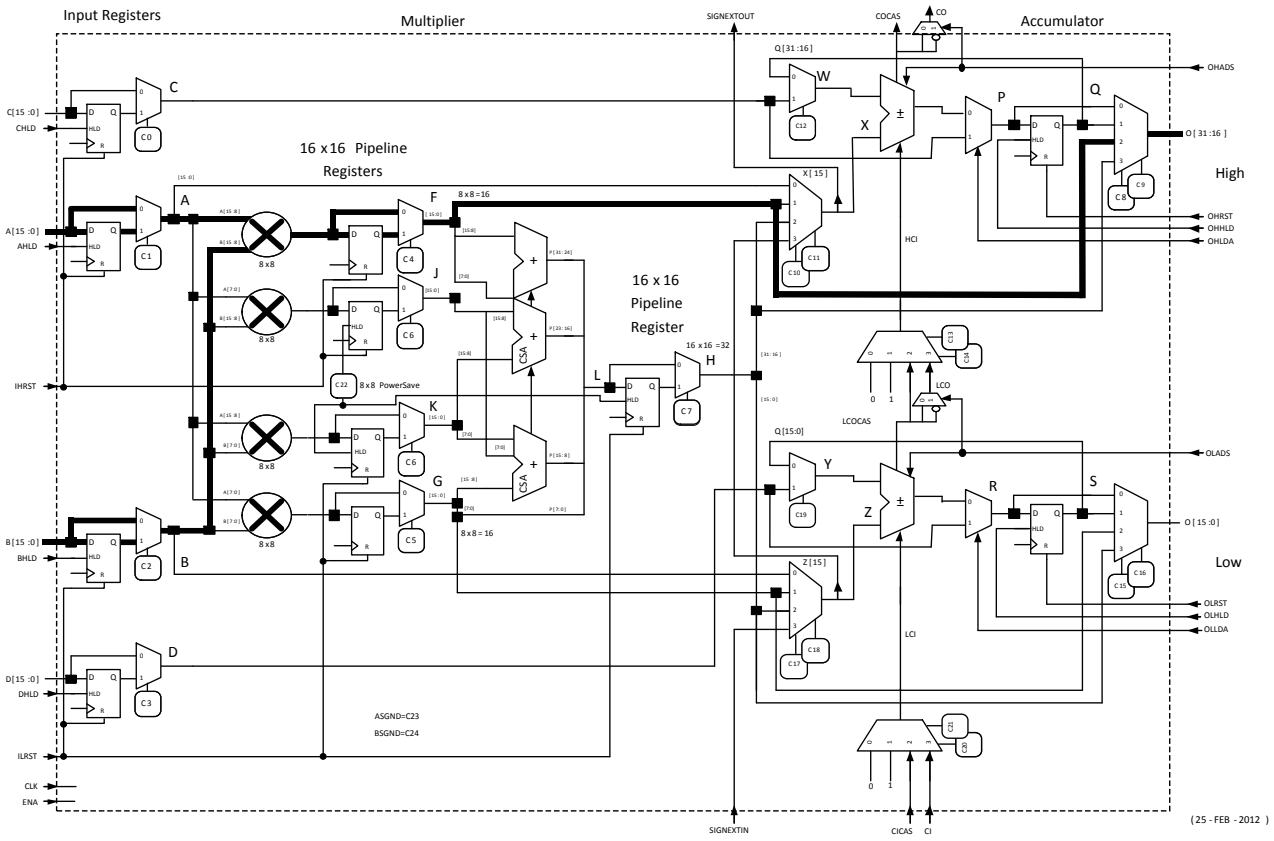

Figure 3.7. sysDSP 8-bit x 8-bit Multiplier

Figure 3.8 shows the path for an 16-bit x 16-bit Multiplier using the upper half of sysDSP block.

3.1.11. User I²C IP

The iCE40 UltraPlus devices have two I²C IP cores. Either of the two cores can be configured either as an I²C master or as an I²C slave. The pins for the I²C interface are not pre-assigned. User can use any General Purpose I/O pins.

In each of the two cores, there are options to delay the either the input or the output, or both, by 50 ns nominal, using dedicated on-chip delay elements. This provides an easier interface with any external I²C components.

When the IP core is configured as master, it will be able to control other devices on the I²C bus through the pre-assigned pin interface. When the core is configured as the slave, the device will be able to provide I/O expansion to an I²C Master. The I²C cores support the following functionality:

- Master and Slave operation
- 7-bit and 10-bit addressing
- Multi-master arbitration support
- Clock stretching
- Up to 400 kHz data transfer speed
- General Call support
- Optionally delaying input or output data, or both
- Optional filter on SCL input

For further information on the User I²C, refer to TN1274, iCE40 SPI/I2C Hardened IP Usage Guide.

3.1.12. User SPI IP

The iCE40 UltraPlus devices have two SPI IP cores. The pins for the SPI interface are not pre-assigned. User can use any General Purpose I/O pins. Both SPI IP cores can be configured as a SPI master or as a slave. When the SPI IP core is configured as a master, it controls the other SPI enabled devices connected to the SPI Bus. When SPI IP core is configured as a slave, the device will be able to interface to an external SPI master.

The SPI IP core supports the following functions:

- Configurable Master and Slave modes
- Full-Duplex data transfer
- Mode fault error flag with CPU interrupt capability
- Double-buffered data register
- Serial clock with programmable polarity and phase
- LSB First or MSB First Data Transfer

For further information on the User SPI, refer to TN1274, iCE40 SPI/I2C Hardened IP Usage Guide.

3.1.13. RGB High Current Drive I/O Pins

The iCE40 UltraPlus family devices offer multiple high current LED drive outputs in each device in the family to allow the iCE40 UltraPlus product to drive LED signals directly on mobile applications.

There are three outputs on each device that can sink up to 24 mA current. These outputs are open-drain outputs, and provides sinking current to an LED connecting to the positive supply. These three outputs are designed to drive the RBG LEDs, such as the service LED found in a lot of mobile devices. This RGB drive current is user programmable from 4 mA to 24 mA, in increments of 4 mA. This output functions as General Purpose I/O with open-drain when the high current drive is not needed.

3.1.14. RGB PWM IP

To provide an easier usage of the RGB high current drivers to drive RGB LED, a Pulse-Width Modulator IP can be used in the user design. This PWM IP provides the flexibility for user to dynamically change the modulation width of each of the RGB LED driver, which changes the color. Also, the user can dynamically change the settings on the ON-time duration, OFF-time duration, and ability to turn the LED lights on and off gradually with user set breath-on and breath-off time.

For additional information on the PWM IP, refer to TN1288, iCE40 LED Driver Usage Guide.

3.1.15. Non-Volatile Configuration Memory

All iCE40 UltraPlus devices provide a Non-Volatile Configuration Memory (NVCM) block which can be used to configure the device.

For more information on the NVCM, refer to TN1248, iCE40 Programming and Configuration.

3.2. iCE40 UltraPlus Programming and Configuration

This section describes the programming and configuration of the iCE40 UltraPlus family.

3.2.1. Device Programming

The NVCM memory can be programmed through the SPI port. The SPI port is located in Bank 1, using SPI_V_{CCIO1} power supply.

3.2.2. Device Configuration

There are various ways to configure the Configuration RAM (CRAM), using SPI port, including:

- From a SPI Flash (Master SPI mode)
- System microprocessor to drive a Serial Slave SPI port (SSPI mode)

For more details on configuring the iCE40 UltraPlus, refer to TN1248, iCE40 Programming and Configuration.

3.2.3. Power Saving Options

The iCE40 UltraPlus devices feature iCEGate and PLL low power mode to allow users to meet the static and dynamic power requirements of their applications. Table 3.11 describes the function of these features.

Table 3.11. iCE40 UltraPlus Power Saving Features Description

Device Subsystem	Feature Description
PLL	When LATCHINPUTVALUE is enabled, puts the PLL into low-power mode; PLL output held static at last input clock value.
iCEGate	To save power, the optional iCEGate latch can selectively freeze the state of individual, non-registered inputs within an I/O bank. Registered inputs are effectively frozen by their associated clock or clock-enable control.

4.11. User I²C Specifications

Table 4.7. User I²C Specifications

Symbol	Parameter	Spec (STD Mode)			Spec (FAST Mode)			Unit
		Min	Typ	Max	Min	Typ	Max	
f_{SCL}	Maximum SCL clock frequency	—	—	100	—	—	400	kHz
t_{HI}	SCL clock HIGH Time	4	—	—	0.6	—	—	µs
t_{LO}	SCL clock LOW Time	4.7	—	—	1.3	—	—	µs
$t_{SU,DAT}$	Setup time (DATA)	250	—	—	100	—	—	ns
$t_{HD,DAT}$	Hold time (DATA)	0	—	—	0	—	—	ns
$t_{SU,STA}$	Setup time (START condition)	4.7	—	—	0.6	—	—	µs
$t_{HD,STA}$	Hold time (START condition)	4	—	—	0.6	—	—	µs
$t_{SU,STO}$	Setup time (STOP condition)	4	—	—	0.6	—	—	µs
t_{BUF}	Bus free time between STOP and START	4.7	—	—	1.3	—	—	µs
$t_{CO,DAT}$	SCL LOW to DATAOUT valid	—	—	3.4	—	—	0.9	µs

4.12. I²C 50 ns Delay

Table 4.8. I²C 50 ns Delay

Symbol	Parameter	Spec			Unit
		Min	Typ	Max	
T_{DELAY}	Delay through 50 ns Delay Block	—	50	—	ns

4.13. I²C 50 ns Filter

Table 4.9. I²C 50 ns Filter

Symbol	Parameter	Spec			Unit
		Min	Typ	Max	
$T_{FILTER-H}$	HIGH Pulse Filter through 50 ns Filter Block	—	50	—	ns
$T_{FILTER-L}$	LOW Pulse Filter through 50 ns Filter Block	—	50	—	ns

4.14. User SPI Specifications [1, 2]

Table 4.10. User SPI Specifications

Symbol	Parameter	Min	Typ	Max	Unit
f_{MAX}	Maximum SCK clock frequency	—	—	45	MHz

Notes:

1. All setup and hold time parameters on external SPI interface are design-specific and, therefore, generated by the Lattice Design Software too. These parameters include the following:
   - $t_{SUmaster}$ master Setup Time (master mode)
   - $t_{HOLDmaster}$ master Hold time (master mode)
   - $t_{SUslave}$ slave Setup Time (slave mode)
   - $t_{HOLDslave}$ slave Hold time (slave mode)
   - $t_{SCK2OUT}$ SCK to Out Delay (slave mode)
2. The SCLK duty cycle needs to be specified in the Lattice Design Software as a timing constraint in order to ensure proper timing check on SCLK HIGH and LOW (t_{HI}, t_{LO}) time.

4.15. Internal Oscillators (HFOSC, LFOSC)

Table 4.11. Internal Oscillators (HFOSC, LFOSC)

Parameter		Parameter Description	Spec/Recommended			Unit
Symbol	Conditions		Min	Typ	Max	
f_{CLKHF}	Commercial Temp	HFOSC clock frequency (t_J = 0 °C–85 °C)	-10%	48	10%	MHz
	Industrial Temp	HFOSC clock frequency (t_J = –40 °C–100 °C)	-20%	48	20%	MHz
f_{CLKLF}	—	LFOSC CLKK clock frequency	-10%	10	10%	kHz
DCH_{CLKHF}	Commercial Temp	HFOSC Duty Cycle (t_J = 0 °C–85 °C)	45	50	55	%
	Industrial Temp	HFOSC Duty Cycle (t_J = –40 °C–100 °C)	40	50	60	%
DCH_{CLKLF}	—	LFOSC Duty Cycle (Clock High Period)	45	50	55	%
Tsync_on	—	Oscillator output synchronizer delay	—	—	5	Cycles
Tsync_off	—	Oscillator output disable delay	—	—	5	Cycles

Note: Glitchless enabling and disabling OSC clock outputs.

4.16. sysI/O Recommended Operating Conditions

Table 4.12. sysI/O Recommended Operating Conditions

Standard	V_{CCIO} (V)		
	Min	Typ	Max
LVCMOS 3.3	3.14	3.3	3.46
LVCMOS 2.5	2.37	2.5	2.62
LVCMOS 1.8	1.71	1.8	1.89

4.17. sysI/O Single-Ended DC Electrical Characteristics

Table 4.13. sysI/O Single-Ended DC Electrical Characteristics

Input/Output Standard	V_{IL}		V_{IH}		V_{OL} Max (V)	V_{OH} Min (V)	I_{OL}* (mA)	I_{OH} Max (mA)
	Min (V)	Max (V)	Min (V)	Max (V)				
LVCMOS 3.3	–0.3	0.8	2.0	V_{CCIO}+0.2 V	0.4	V_{CCIO} – 0.4	8	–8
					0.2	V_{CCIO} – 0.2	0.1	–0.1
LVCMOS 2.5	–0.3	0.7	1.7	V_{CCIO}+0.2 V	0.4	V_{CCIO} – 0.4	6	–6
					0.2	V_{CCIO} – 0.2	0.1	–0.1
LVCMOS 1.8	–0.3	0.35 V_{CCIO}	0.65 V_{CCIO}	V_{CCIO}+0.2 V	0.4	V_{CCIO} – 0.4	4	–4
					0.2	V_{CCIO} – 0.2	0.1	–0.1

4.23. Maximum sysIO Buffer Performance

Table 4.19. Maximum sysIO Buffer Performance

I/O Standard	Max Speed	Unit
Inputs		
LVCMOS33	250	MHz
LVCMOS25	250	MHz
LVCMOS18	250	MHz
Outputs		
LVCMOS33	250	MHz
LVCMOS25	250	MHz
LVCMOS18	155	MHz
LVCMOS12	70	MHz

Note: Measured with a toggling pattern.

4.24. iCE40 UltraPlus Family Timing Adders

Over recommended commercial operating conditions.

Table 4.20. iCE40 UltraPlus Family Timing Adders

Buffer Type	Description	Timing (Typ)	Units
Input Adjusters			
LVCMOS33	LVCMOS, V_{CCIO} = 3.3 V	0.18	ns
LVCMOS25	LVCMOS, V_{CCIO} = 2.5 V	0	ns
LVCMOS18	LVCMOS, V_{CCIO} = 1.8 V	0.19	ns
Output Adjusters			
LVCMOS33	LVCMOS, V_{CCIO} = 3.3 V	-0.12	ns
LVCMOS25	LVCMOS, V_{CCIO} = 2.5 V	0	ns
LVCMOS18	LVCMOS, V_{CCIO} = 1.8 V	1.32	ns
LVCMOS12	LVCMOS, V_{CCIO} = 1.2 V	5.38	ns

Notes:

1. Timing adders are relative to LVCMOS25 and characterized but not tested on every device.
2. LVCMOS timing measured with the load specified in Switching Test Condition table.
3. Commercial timing numbers are shown.

4.26. sysCLOCK PLL Timing

Over recommended operating conditions.

Table 4.22. sysCLOCK PLL Timing

Parameter	Descriptions	Conditions	Min	Max	Unit
f_{IN}	Input Clock Frequency (REFERENCECLK, EXTFEEDBACK)	—	10	133	MHz
f_{OUT}	Output Clock Frequency (PLLOUT)	—	16	275	MHz
f_{VCO}	PLL VCO Frequency	—	533	1066	MHz
f_{PFD}[3]	Phase Detector Input Frequency	—	10	133	MHz
AC Characteristics					
t_{DT}	Output Clock Duty Cycle	—	40	60	%
t_{PH}	Output Phase Accuracy	—	—	±12	deg
t_{OPJIT}[1, 5, 6]	Output Clock Period Jitter	f_{OUT} >= 100 MHz	—	450	ps p-p
		f_{OUT} < 100 MHz	—	0.05	UIPP
	Output Clock Cycle-to-Cycle Jitter	f_{OUT} >= 100 MHz	—	750	ps p-p
		f_{OUT} < 100 MHz	—	0.10	UIPP
	Output Clock Phase Jitter	f_{PFD} >= 25 MHz	—	275	ps p-p
		f_{PFD} < 25 MHz	—	0.05	UIPP
t_W	Output Clock Pulse Width	At 90% or 10%	1.33	—	ns
t_{LOCK}[2, 3]	PLL Lock-in Time	—	—	50	µs
t_{UNLOCK}	PLL Unlock Time	—	—	50	ns
t_{IPJIT}[4]	Input Clock Period Jitter	f_{PFD} ≥ 20 MHz	—	1000	ps p-p
		f_{PFD} < 20 MHz	—	0.02	UIPP
t_{STABLE}[3]	LATCHINPUTVALUE LOW to PLL Stable	—	—	500	ns
t_{STABLE_PW}[3]	LATCHINPUTVALUE Pulse Width	—	100	—	ns
t_{RST}	RESET Pulse Width	—	10	—	ns
t_{RSTREC}	RESET Recovery Time	—	10	—	µs
$t_{DYNAMIC\_WD}$	DYNAMICDELAY Pulse Width	—	100	—	VCO Cycles

Notes:

1. Period jitter sample is taken over 10,000 samples of the primary PLL output with a clean reference clock. Cycle-to-cycle jitter is taken over 1000 cycles. Phase jitter is taken over 2000 cycles. All values per JESD65B.
2. Output clock is valid after t_{LOCK} for PLL reset and dynamic delay adjustment.
3. At minimum f_{PFD}. As the f_{PFD} increases the time will decrease to approximately 60% the value listed.
4. Maximum limit to prevent PLL unlock from occurring. Does not imply the PLL will operate within the output specifications listed in this table.
5. The jitter values will increase with loading of the PLD fabric and in the presence of SSO noise.

4.27. SPI Master or NVCM Configuration Time

Table 4.23. SPI Master or NVCM Configuration Time

Symbol	Parameter	Conditions	Max	Unit
t_{CONFIG}	POR/CRESET_B to Device I/O Active	All devices – Low Frequency (Default)	140	ms
		All devices – Medium frequency	50	ms
		All devices – High frequency	26	ms

Notes:

1. Assumes sysMEM Block is initialized to an all zero pattern if they are used.
2. The NVCM download time is measured with a fast ramp rate starting from the maximum voltage of POR trip point.

4.28. sysCONFIG Port Timing Specifications

Over recommended operating conditions.

Table 4.24. sysCONFIG Port Timing Specifications

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
All Configuration Mode						
t_{CRESET_B}	Minimum CRESET_B LOW pulse width required to restart configuration, from falling edge to rising edge		200	—	—	ns
t_{DONE_IO}	Number of configuration clock cycles after CDONE goes HIGH before the PIO pins are activated		49	—	—	Clock Cycles
Slave SPI						
t_{CR_SCK}	Minimum time from a rising edge on CRESET_B until the first SPI WRITE operation, first SPI_XCK clock. During this time, the iCE40 UltraPlus device is clearing its internal configuration memory		1200	—	—	µs
f_{MAX}	CCLK clock frequency	Write	1	—	25	MHz
		Read[1]	—	15	—	MHz
t_{CCLKH}	CCLK clock pulsewidth HIGH		20	—	—	ns
t_{CCLKL}	CCLK clock pulsewidth LOW		20	—	—	ns
t_{STSU}	CCLK setup time		12	—	—	ns
t_{STH}	CCLK hold time		12	—	—	ns
t_{STCO}	CCLK falling edge to valid output		13	—	—	ns
Master SPI[3]						
f_{MCLK}	MCLK clock frequency	Low Frequency	7.0	12.0	17.0	MHz
		Medium Frequency[2]	21.0	33.0	45.0	MHz
		High Frequency[2]	33.0	53.0	71.0	MHz
t_{MCLK}	CRESET_B HIGH to first MCLK edge		1200	—	—	µs
t_{SU}	CCLK setup time		6.16	—	—	ns
t_{HD}	CCLK hold time		1	—	—	ns

Notes:

1. Supported with 1.2 V V_{CC} and at 25 °C.
2. Extended range f_{MAX} Write operations support up to 53 MHz with 1.2 V V_{CC} and at 25 °C.
3. t_{SU} and t_{HD} timing must be met for all MCLK frequency choices.

4.29. RGB LED Drive

Table 4.25. RGB LED

Symbol	Parameter	Min	Max	Unit
ILED_ACCURACY	RGB0, RGB1, RGB2 Sink Current Accuracy to selected current @ V_{LEDOUT} >= 0.5 V	–12	+12	%
ILED_MATCH	RGB0, RGB1, RGB2 Sink Current Matching among the 3 outputs @ V_{LEDOUT} >= 0.5	–5	+5	%

4.30. Switching Test Conditions

Figure 4.3 shows the output test load that is used for AC testing. The specific values for resistance, capacitance, voltage, and other test conditions are listed in Table 4.26..

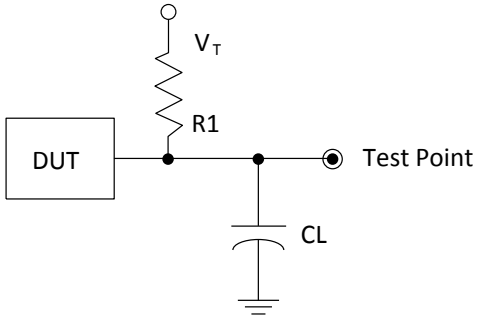

Figure 4.3. Output Test Load, LVCMOS Standards

Table 4.26. Test Fixture Required Components, Non-Terminated Interfaces

Test Condition	R_1	C_L	Timing Reference	V_T
LVCMOS settings (L ≥ H, H ≥ L)	∞	0 pF	LVCMOS 3.3 = 1.5 V	—
			LVCMOS 2.5 = $V_{CCIO}/2$	—
			LVCMOS 1.8 = $V_{CCIO}/2$	—
LVCMOS 3.3 (Z ≥ H)	188	0 pF	1.5 V	V_{OL}
LVCMOS 3.3 (Z ≥ L)			1.5 V	V_{OH}
Other LVCMOS (Z ≥ H)			$V_{CCIO}/2$	V_{OL}
Other LVCMOS (Z ≥ L)			$V_{CCIO}/2$	V_{OH}
LVCMOS (H ≥ Z)			V_{OH} – 0.15 V	V_{OL}
LVCMOS (L ≥ Z)			V_{OL} – 0.15 V	V_{OH}

Note: Output test conditions for all other interfaces are determined by the respective standards.

Supplemental Information

For Further Information

A variety of technical documents for the iCE40 UltraPlus family are available on the Lattice web site.

- TN1248, iCE40 Programming and Configuration
- TN1274, iCE40 SPI/I2C Hardened IP Usage Guide
- TN1276, Advanced iCE40 SPI/I2C Hardened IP Usage Guide
- TN1250, Memory Usage Guide for iCE40 Devices
- TN1251, iCE40 sysCLOCK PLL Design and Usage Guide
- TN1252, iCE40 Hardware Checklist
- TN1288, iCE40 LED Driver Usage Guide
- TN1295, DSP Function Usage Guide for iCE40 Devices
- TN1296, iCE40 Oscillator Usage Guide
- TN1314, iCE40 SPRAM Usage Guide
- iCE40 UltraPlus Pinout Files
- iCE40 UltraPlus Pin Migration Files
- Thermal Management document
- Package Diagrams
- Lattice design tools

Revision History

Date	Version	Section	Change Summary
February 2017	1.3	All	— Changed document status from Advance to Preliminary. — Updated footer.
		Architecture	— Corrected link to TN1288, iCE40 LED Driver Usage Guide. — Added link to TN1314, iCE40 SPRAM Usage Guide.
		DC and Switching Characteristics	— Updated Typ V_{CC}=1.2 V values for $I_{PP\_2VSPEAK}$ and $I_{COOPEAK}$ in Table 4.6. Supply Current. — Added Min value for $f_{MAXSRAM}$ to Table 4.18. Single Port RAM Timing. — Added LVCMOS12 information to Table 4.19. Maximum sysIO Buffer Performance and Table 4.20. iCE40 UltraPlus Family Timing Adders. — Updated Table 4.21. iCE40 UltraPlus External Switching Characteristics. Revised Max values for t_{ISKEW_GBUF}, t_{SKEW_IO}, t_{CO}, t_{COPLL}, and Min values for t_{SUPLL}, t_{HPLL}. — Added Max values to Table 4.23. SPI Master or NVCM Configuration Time.
		Pinout Information	— Updated TR description in the iCE40UP Part Number Description section. — Updated part number information in the Ordering Part Numbers section.
		Supplemental Information	— Corrected link to TN1288, iCE40 LED Driver Usage Guide. — Added link to TN1314, iCE40 SPRAM Usage Guide. — Added link to Package Diagrams.
June 2016	1.2	All	Updated template.
		Introduction	Added QFN package in features list.
		Product Family	Added packages to Table 2.1 iCE40 UltraPlus Family Selection Guide. Added information on RGB PWM IP in Overview.
		Architecture	— Performed minor editorial changes. — Added information on 256 kb SPRAM blocks. — Changed headings in Table 3.2. Global Buffer (GBUF) Connections to Programmable Logic Blocks. — Corrected VCCPLL format in Figure 3.3. PLL Diagram. — Updated note in Table 3.4. sysMEM Block Configurations. — Added reference to TN1314, iCE40 SPRAM Usage Guide. — Revised sysIO Buffer Banks information. — Corrected VCCIO format in Figure 3.9. I/O Bank and Programmable I/O Cell. — Revised Typical I/O Behavior During Power-up information. — Revised Supported Standards information. — Revised heading in Table 3.9. Supported Input Standards. — Revised heading and removed LVCMOS12 in Table 3.10. Supported Output Standards. — Revised HFOSC information in On-Chip Oscillator section. — Removed "An RGB PWM IP is also offered in the family." in RGB High Current Drive I/O Pins section.